

Notice of References Cited	Application/Control No. 10/522,155		Applicant(s)/Patent Under Reexamination CHOUNO ET AL.	
	Examiner Satish Chandra		Art Unit 1763	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0178145	09-2003	Anderson et al.	156/345.51
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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